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Scanning tunneling microscopy of the charge density wave in 1T-TiSe₂ in the presence of single atom defects

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We present a detailed low-temperature scanning tunneling microscopy (STM) study of the commensurate charge density wave (CDW) in 1T-TiSe₂ in the presence of single atom defects. We find no significant modification of the CDW lattice in single crystals with native defect concentrations where some bulk probes already measure substantial reductions in the CDW phase transition signature. A systematic analysis of STM micrographs combined with density functional theory modeling of atomic defect patterns indicate that the observed CDW modulation lies in the Se surface layer. The defect patterns clearly show there are no 2H-polytype inclusions in the CDW phase, as previously found at room temperature [A. N. Titov *et al.*, *Phys. Solid State* **53**, 1073 (2011)]. They further provide an alternative explanation for the chiral Friedel oscillations recently reported in this compound [J. Ishioka *et al.*, *Phys. Rev. B* **84**, 245125 (2011)].

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The transition metal dichalcogenide (TMD) 1T-TiSe₂ has kept the scientific community wondering about a number of its striking physical properties for more than four decades [1–7]. 1T-TiSe₂ is a layered compound consisting of a hexagonal layer of Ti sandwiched between two hexagonal layers of Se to form Se-Ti-Se sandwiches that stack via weak van der Waals (vdW) forces to form a single crystal. The band structure of 1T-TiSe₂, as determined by angle-resolved photoemission spectroscopy, consists primarily of a Se 4*p* valence band at the Γ point and a Ti 3*d* conduction band at the *L* point of the Brillouin zone. But it is still debated whether it is a semiconductor or a semimetal, with evidence claimed for both alternatives [6,8–10].

Below $T_{\text{CDW}} \approx 202$ K, 1T-TiSe₂ undergoes a second-order phase transition into a commensurate charge density wave (CDW). A comprehensive theory of this CDW formation is yet to be developed. Two main mechanisms are currently considered, driven either by a Jahn-Teller distortion [4,11] or an excitonic ground state [2,9,12,13]. The CDW phase has been found to melt upon copper intercalation [5] or when applying pressure [7]. In both instances, superconductivity develops in a dome-shaped region around some optimal doping or optimal pressure, with a maximum critical temperature of 4.1 and 1.8 K, respectively. More recently, chiral properties have been reported for the CDW in pristine and copper intercalated 1T-TiSe₂ based on polarized optical reflectometry and scanning tunneling microscopy (STM) [14–16].

Here, we focus on the CDW instability in 1T-TiSe₂ in the presence of native atomic scale defects. Past studies performed using macroscopic probes including resistivity, magnetic susceptibility, and optical reflectivity have found atomic intercalation and substitution to be detrimental to the

CDW [1,17]. This compound is usually nonstoichiometric, with a strong correlation between increasing crystal growth temperature and Ti self-doping leading to the collapse of the CDW phase transition signature in temperature dependent resistivity measurements [1]. STM offers different opportunities in allowing the simultaneous mapping of individual single atom defects and the CDW in real space, as well as measuring the local density of states (LDOS) around the Fermi level by tunneling spectroscopy. This technique has revealed a distorted CDW superlattice in doped 1T-TaS₂ [18,19], a one-dimensional (1D) CDW in calcium intercalated graphite [20] and a finite CDW amplitude in the vicinity of intrinsic defects in 2H-NbSe₂ well above the bulk T_{CDW} [21]. These examples highlight the possibility to gain insight into the CDW phase and its formation mechanism by means of STM in the presence of atomic defects and impurities.

1T-TiSe₂ single crystals were grown by iodine vapor transport and cleaved *in situ* below 10^{-7} mbar at room temperature. All measurements were performed on crystals grown at 650 °C, except for the micrograph in Fig. 3(j) that was acquired on a crystal grown at 575 °C to better observe atomic features unrelated to intercalated Ti. Constant current STM micrographs were recorded at 4.7 K using an Omicron low-temperature STM (LT-STM) and a SPECS Joule-Thomson STM (JT-STM), with the bias voltage V_{bias} applied to the sample. In both cases, the base pressure was better than 5×10^{-11} mbar. Density functional theory (DFT) model calculations were performed using the plane-wave pseudopotential code VASP [22,23], version 5.3.3. Projector-augmented waves [24] were used with the Perdew-Burke-Ernzerhof (PBE) [25] exchange correlation functional and plane-wave cutoffs of 211 eV (1T-TiSe₂, I substitutional) and 400 eV (O). The cell size of our model was $28.035 \text{ \AA} \times 28.035 \text{ \AA}$. The 1T-TiSe₂ surface was modeled with two layers and the bottom Se layer fixed. A Monkhorst-Pack mesh with $2 \times 2 \times 1$ *k* points was used to sample the Brillouin zone of the

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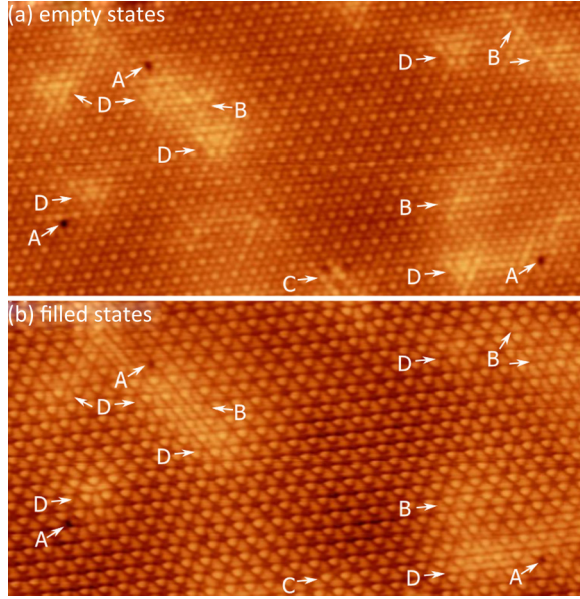


FIG. 1. (Color online) Simultaneously measured empty-state [(a) $V_{\text{bias}} = 0.15$ V] and filled-state [(b) $V_{\text{bias}} = -0.15$ V] STM micrographs of a 1T-TiSe₂ single crystal grown at 650 °C. Image size: 22.2 nm \times 11.4 nm, $I_t = 0.2$ nA, $T = 4.7$ K. Native defects are labeled A, B, C, and D.

cell. The parameters gave an energy difference convergence of better than 0.01 eV. During structural relaxations, a tolerance of 0.03 eV/Å was applied. STM images were generated using the Tersoff-Hamann approach [26] in which the current $I(V)$ measured in STM is proportional to the integrated LDOS of the surface using the BSKAN code [27].

Figure 1 shows two high-resolution STM micrographs of 1T-TiSe₂ obtained at $T = 4.7$ K with exactly the same tip at the positive and negative sample bias [28]. The bias voltages of ± 150 mV have been chosen to enable the simultaneous resolution of the $2a_0 \times 2b_0$ CDW reconstruction on the selenium layer and atomic lattice features at opposite polarities. Defects (A–D) correspond to the dominant native atomic defects in 1T-TiSe₂ identified in a recent STM/DFT study based on images recorded at a larger bias voltage where the CDW is not resolved [29]. These defects are Se surface vacancies (A), iodine (B), and oxygen (C) substitution for bulk Se, and titanium intercalated into the vdW gap (D). Their positions in the lattice unit cell are shown in Fig. 2.

1T-TiSe₂ cleaves between the weakly vdW bonded Se-Ti-Se sandwiches, thus exposing a hexagonal Se layer to the surface. DFT modeling enables us to identify the atomic lattice seen in STM maps with the Se surface layer by assigning the observed vacancies (defect A) to missing Se surface atoms [29]. Thus, the commensurate in-plane $2a_0 \times 2b_0$ modulation (Fig. 1) is in perfect registry with the Se atomic lattice, indicating that the CDW charge modulation detected by STM resides in the Se layer.

As a consequence of the CDW modulation, there are two inequivalent sites in the unit cell for each defect, with three times more 3/4 than 1/4 sites [Fig. 2(b)]. A survey of Se, O, and Ti defects in a large area map (50 \times 50 nm², 23 000 unit cells, 177 defects in total) yields approximately three

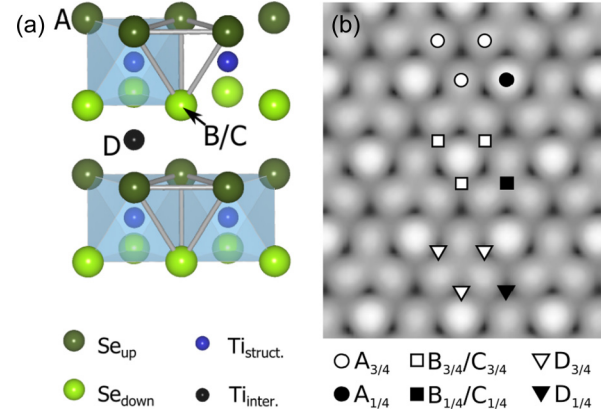


FIG. 2. (Color online) (a) Ball-and-stick model of the 1T-TiSe₂ lattice showing the positions of the native defects A–D. (b) Model representation of the inequivalent 1/4 (solid symbols) and 3/4 (open symbols) lattice sites for defects A–D in the commensurate CDW phase.

times more 3/4 than 1/4 configurations for each of them. This uniform statistical distribution of all native defects among 3/4 and 1/4 sites implies they do not interact strongly with the CDW in this crystal, even though its resistive CDW transition is reduced by over 30% compared to a sample with optimal stoichiometry. If they were interacting, we would expect dislocations to enable the CDW lattice to accommodate the random defect landscape. Indeed, we find no systematic domain formation, dislocations, or weakening of the CDW lattice due to native defects. This rigidity of the CDW can be directly linked to its commensurate nature in 1T-TiSe₂ [30]. In the same survey, we count about 80 intercalated Ti (defect D), corresponding to 0.35% self-doping, in excellent agreement with literature for samples grown at 650 °C [1].

Se vacancies appear as well-resolved dark sites independent on bias voltage and position at the surface [Figs. 3(a)–3(c)]. In contrast, defects B–D are mostly bright and best resolved and differentiated at positive V_{bias} (Fig. 1). Their characteristic patterns revealed by STM [29] are slightly modified in the presence of the CDW and depend on their 1/4 or 3/4 configuration (Figs. 3 and 4). Of all defects, iodine substitution for Se_{down} (defect B) is the most difficult to identify. On the 1/4 site, it appears as a faint enhancement of the three nearest CDW maxima [Fig. 3(e)]. The 3/4 configuration appears as a few atoms long brighter chain extending along one of the crystallographic direction [Fig. 3(d)]. Similar bright atomic chain features are found around defect A [Figs. 3(a) and 3(j)]. DFT simulations of defects A and B are in good agreement with these experimental observations [Figs. 3(c) and 3(f)]. The linear features are reproduced in the model without including the CDW instability. This shows they are not a different CDW ground state (e.g., 1D CDW), but reflect local strain due to the Se vacancy and the larger atomic radius of iodine compared to Se. In regions with higher defect densities, these chains cooperate to form stripy patches in the STM topography, but without disrupting the long-range coherent CDW [Fig. 3(j)]. The defects in these regions will produce an anisotropic deformation landscape explaining why these stripes do not always appear in all three high symmetry directions with the

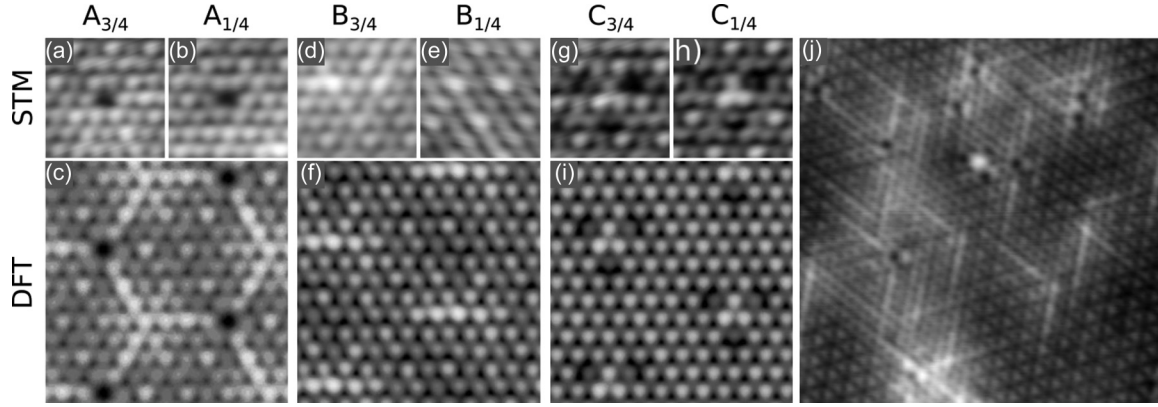


FIG. 3. High-resolution STM micrographs centered on Se vacancies [(a), (b)], iodine [(d), (e)] and oxygen [(g), (h)] substitutions at 3/4 sites [(a), (d), (g)] and 1/4 sites [(b), (e), (h)] with corresponding DFT simulations calculated without including the CDW [(c), (f), (i)]. (j) Linear features around defects A and B observed by STM on 1*T*-TiSe₂ grown (11.5 × 11.5 nm², $V_{\text{bias}} = +150$ mV, $I_t = 0.2$ nA). All images are taken on crystals grown at 650 °C, except for image (j) recorded on a sample grown at 575 °C to have a reduced number of intercalated Ti.

same intensity. When the defect density is low and in the vicinity of intercalated Ti (defect D), these stripes are usually less or not visible [Fig. 1(a)].

Defects C and D show more complex triangular patterns without the linear atomic features found around defects A and B. Oxygen substitution for Se_{down} (defect C) is characterized by three bright central atoms centered on a larger, 60° rotated triangle of three dark atoms [Figs. 3(g) and 3(h)], in perfect agreement with DFT modeling [Fig. 3(i)]. Titanium interstitials (defect D) appear as two concentric bright triangles centered on the defect (Fig. 4) [29]. The central triangles point in opposite directions in defect C compared to defect D. The triangular outline of defects C and D always point in the same direction in a given experiment (Fig. 1), attesting to the perfect crystalline structure of our 1*T*-TiSe₂ specimen. The unique triangle orientation and the perfect match between the data and the DFT models, which were all calculated in the 1*T*-polytype structure, imply there are no 2*H*-polytype inclusions where the coordination of the Ti atom changes from octahedral (1*T*) to trigonal-prismatic (2*H*), as found by Titov *et al.* at room temperature [31]. Although this finding cannot exclude a Jahn-Teller mechanism for the CDW origin [4,11],

the capability of locally identifying the 1*T* phase may become instrumental in clarifying the role of local lattice modifications in the CDW formation.

The appearance of all native defects, except surface Se vacancies (defect A), change slightly depending on their 1/4 or 3/4 configuration. At positive sample bias, the oxygen substitution (defect C) in the 1/4 configuration totally obscures the amplitude of the three nearest CDW maxima [Fig. 3(h)] whereas iodine on the same location (defect B) enhances them slightly [Fig. 3(e)]. Intercalated titanium (defect D) has an unmistakable triangular signature, with very sharp vertices in the 1/4 configuration that become nearly extinct in the 3/4 configuration. These different appearances of native atomic defects depending on their configuration (1/4 or 3/4) suggest another explanation for the recently reported chiral Friedel oscillations. Our data and DFT modeling show that the distinct left- and right-handed patterns discussed by Ishioka *et al.* [15] correspond in fact to different native defects (O and I substitutions) in the two distinct 1/4 and 3/4 configurations, unrelated to chirality.

The native defects are poorly resolved in the negative low bias STM micrographs discussed here, except for intercalated Ti (defect D) in the 1/4 configuration and Se vacancies (defect A). The dark sites associated with Se vacancies (defect A) correspond to *holes* in the topography and are seen as such at both polarities. The other defect patterns are primarily electronic and their bias polarity dependent visibility observed here is consistent with a CDW gap that is biased towards occupied states at the Fermi level [16]. A striking exception to this behavior is defect D, which is nicely resolved in the 1/4 configuration at $V_{\text{bias}} < 0$ [Figs. 1(b) and 4(c)], closely matching the DFT modeling. The donor nature of intercalated Ti contributing electron states just above the occupied edge of the CDW gap [29] can explain the finite contrast of defect D at negative bias inside the CDW gap. However, it is presently not clear why only the 1/4 configuration is resolved at $V_{\text{bias}} = -150$ mV [Fig. 4(c)] while the 3/4 configuration remains invisible [Fig. 4(a)]. This question demands further investigation, in particular, in the context of a proposed excitonic ground state [2,3].

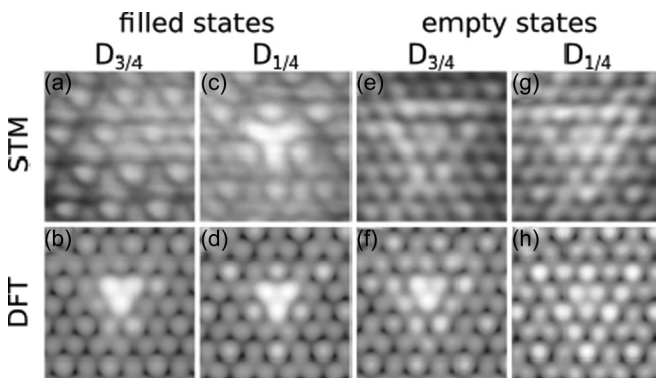


FIG. 4. High-resolution STM micrographs centered on intercalated Ti at 3/4 sites [(a), (e)] and 1/4 sites [(c), (g)] with corresponding DFT simulations in the presence of the CDW [(b), (d), (f), (h)]. (a)–(d) $V_{\text{bias}} = -150$ mV and (e)–(h) $V_{\text{bias}} = +150$ mV, $I_t = 0.2$ nA.

In summary, the careful analysis and comparison with DFT modeling allows us to assign the surface patterns observed in STM micrographs of the CDW phase in $1T$ -TiSe₂ exclusively to Se vacancies, O or I substitutions, and Ti intercalation [29]. We have shown the great potential of high-resolution STM imaging of the CDW in the presence of atomic defects to gain insight into this ordered phase. We find that native defects have essentially no impact on the CDW lattice, at least up to the level of Ti self-doping considered here, where the corresponding phase transition is significantly reduced in transport measurements [1]. The only change, besides the characteristic signatures of each defect, is a locally enhanced brightness linked to their doping nature [29]. The theoretical proposal by McMillan [30] that atomic defects might trigger an incommensurate CDW is clearly not observed here. A comparison with DFT modeling further allows us to

unambiguously demonstrate that the observed defect patterns in the CDW phase are all consistent with the $1T$ polytype, excluding $2H$ -polytype inclusions [31]. Finally, our study sheds a different light on recently published work on the chiral nature of Friedel oscillations in the vicinity of defects [15]. We find compelling evidence that the left- and right-hand patterns identified in that work are the signatures of different $1T$ -TiSe₂ native defects located on inequivalent lattice sites with respect to the CDW modulation.

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A.M.N. and B.H. contributed equally to this work.

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- [1] F. Di Salvo, D. Moncton, and J. Waszczak, *Phys. Rev. B* **14**, 4321 (1976).
 - [2] J. A. Wilson, *Solid State Commun.* **22**, 551 (1977).
 - [3] J. A. Wilson, *Phys. Status Solidi B* **86**, 11 (1978).
 - [4] H. P. Hughes, *J. Phys. C* **10**, 319 (1977).
 - [5] E. Morosan, H. W. Zandbergen, B. S. Dennis, J. W. G. Bos, Y. Onose, T. Klimczuk, A. P. Ramirez, N. P. Ong, and R. J. Cava, *Nat. Phys.* **2**, 544 (2006).
 - [6] J. C. E. Rasch, T. Stemmler, B. Müller, L. Dudy, and R. Manzke, *Phys. Rev. Lett.* **101**, 237602 (2008).
 - [7] A. F. Kusmartseva, B. Sipos, H. Berger, L. Forró, and E. Tutiš, *Phys. Rev. Lett.* **103**, 236401 (2009).
 - [8] D. Greenaway and R. Nitsche, *J. Phys. Chem. Solids* **26**, 1445 (1965).
 - [9] T. Pillo, J. Hayoz, H. Berger, F. Lévy, L. Schlapbach, and P. Aebi, *Phys. Rev. B* **61**, 16213 (2000).
 - [10] G. Monney, C. Monney, B. Hildebrand, P. Aebi, and H. Beck, *Phys. Rev. Lett.* **114**, 086402 (2015).
 - [11] K. Rossnagel, L. Kipp, and M. Skibowski, *Phys. Rev. B* **65**, 235101 (2002).
 - [12] H. Cercellier, C. Monney, F. Clerc, C. Battaglia, L. Despont, M. G. Garnier, H. Beck, P. Aebi, L. Patthey, H. Berger, and L. Forró, *Phys. Rev. Lett.* **99**, 146403 (2007).
 - [13] C. Monney, H. Cercellier, F. Clerc, C. Battaglia, E. F. Schwier, C. Didiot, M. G. Garnier, H. Beck, P. Aebi, H. Berger, L. Forró, and L. Patthey, *Phys. Rev. B* **79**, 045116 (2009).
 - [14] J. Ishioka, Y. H. Liu, K. Shimatake, T. Kurosawa, K. Ichimura, Y. Toda, M. Oda, and S. Tanda, *Phys. Rev. Lett.* **105**, 176401 (2010).
 - [15] J. Ishioka, T. Fujii, K. Katono, K. Ichimura, T. Kurosawa, M. Oda, and S. Tanda, *Phys. Rev. B* **84**, 245125 (2011).
 - [16] M. Iavarone, R. Di Capua, X. Zhang, M. Gholikhani, S. A. Moore, and G. Karapetrov, *Phys. Rev. B* **85**, 155103 (2012).
 - [17] L. S. Krasavin, A. N. Titov, and V. N. Antropov, *Phys. Solid State* **40**, 1962 (1998).
 - [18] X.-L. Wu, P. Zhou, and C. M. Lieber, *Phys. Rev. Lett.* **61**, 2604 (1988).
 - [19] C. M. Lieber and X. L. Wu, *Acc. Chem. Res.* **24**, 170 (1991).
 - [20] K. C. Rahnejat, C. A. Howard, N. E. Shuttleworth, S. R. Schofield, K. Iwaya, C. F. Hirjibehedin, C. Renner, G. Aepli, and M. Ellerby, *Nat. Commun.* **2**, 558 (2011).
 - [21] C. J. Arguello, S. P. Chockalingam, E. P. Rosenthal, L. Zhao, C. Gutiérrez, J. H. Kang, W. C. Chung, R. M. Fernandes, S. Jia, A. J. Millis, R. J. Cava, and A. N. Pasupathy, *Phys. Rev. B* **89**, 235115 (2014).
 - [22] G. Kresse and J. Furthmüller, *Phys. Rev. B* **54**, 11169 (1996).
 - [23] G. Kresse and J. Hafner, *Phys. Rev. B* **47**, 558 (1993).
 - [24] G. Kresse and D. Joubert, *Phys. Rev. B* **59**, 1758 (1999).
 - [25] J. P. Perdew, K. Burke, and M. Ernzerhof, *Phys. Rev. Lett.* **77**, 3865 (1996).
 - [26] J. Tersoff and D. R. Hamann, *Phys. Rev. Lett.* **50**, 1998 (1983).
 - [27] W. Hofer, *Prog. Surf. Sci.* **71**, 147 (2003).
 - [28] Both images were taken simultaneously, with the positive bias being recorded while scanning the tip to the right and the negative bias during the backward scan to the left.
 - [29] B. Hildebrand, C. Didiot, A. M. Novello, G. Monney, A. Scarfato, A. Ubaldini, H. Berger, D. R. Bowler, C. Renner, and P. Aebi, *Phys. Rev. Lett.* **112**, 197001 (2014).
 - [30] W. L. McMillan, *Phys. Rev. B* **12**, 1187 (1975).
 - [31] A. N. Titov, M. V. Kuznetsov, and A. S. Razinkin, *Phys. Solid State* **53**, 1073 (2011).